oPOSsum: SAT Solver Accelerator

ECE 427 Project Proposal

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I. Abstract

***Abstract*—This proposal presents the design and implementation of an SAT solver accelerator, which mainly focuses on boolean constraint propgation (BCP), as it is the bottleneck in traditional SAT solving algorithms.**

II. Introduction

Boolean Satisfiability (SAT) is the problem of finding a set of boolean inputs which finds an assignment of values to the variables in a Product-of-Sums (POS) boolean expression that makes the expression evaluate to true. It has many real-world applications, including but not limited to: hardware verification, logic synthesis, software verification, and even applications as simple as scheduling (classes, sports tournaments, etc). Previous works have implemented software solvers based on the Davis–Putnam–Logemann–Loveland (DPLL) algorithm, but many works thereafter have shown that most of the computation time (80-90%) [1] is spent in doing Boolean Constraint Propagation (BCP). BCP essentially updates which variables still need to be assigned in all clauses still not satisfied (i.e., evaluating to true) after one variable gets assigned a certain value.

We propose an architecture for accelerating BCP which parallelizes updating a variable with evaluation of the clause. Our architecture is based on HW-BCP, a design proposed by Park et al. [1]. However, since we are not able to expose the CAM/SRAM bitlines like they did in the paper, we modified our functional units to only use D flip-flops for storing the clauses, variable values, and polarities.

That said, we leave ourselves open to certain hardware extensions that would make it easy to add clause learning, one of the modern techniques used to accelerate SAT.

III. Architecture

A. Network On Chip

After considering various Network On Chip architectures, we are leaning towards a combination of the Mesh and Torus frameworks, using a flow control digit or FLIT as a unit of communication. There are 3 types of flits, HEAD, BODY and TAIL. HEAD stores the routing information and destination address, BODY stores the actual data to be transmitted, and TAIL is responsible for closing the virtual channels behind it.

1) Switch Boxes: Each BCP unit is connected to a single switch, and each switch is connected to four neighboring switches [2]. The mesh topology services many operations, including but not limited to the initial distribution of clauses to BCP units from the CPU, the propogation of contradictions back to the CPU, as well as the standard BCP protocol.

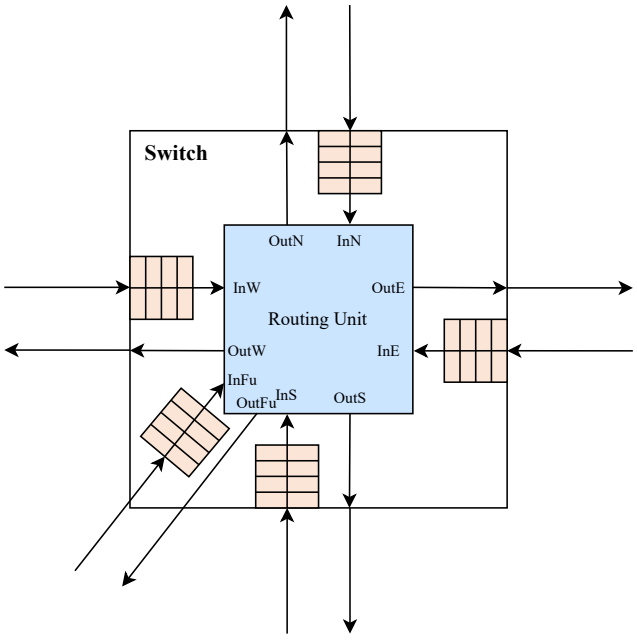

Fig. 1. Switch Block Diagram

Let us denote flits and switches previously along a mes-

sage's path as upstream, and any flits and switches that are further along the path as downstream.

To account for contention within the network-on-chip fabric, each of the five upstream connections (each cardinal direction and the local resource port) have a dedicated circular buffer, as shown in Figure 1. The routing unit then determines which upstream switch is allowed to communicate with which downstream switch, including accounting for verifying if a switch is busy with other communication.

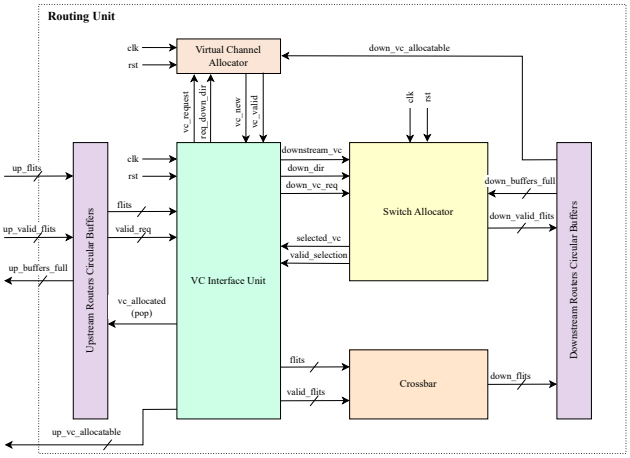

Fig. 2. In-Depth Routing Unit

Compared to standard networking protocols like TCP, such network-on-chip practices are unable to allow for dropped packages. Therefore to account for potential head-of-line blocking and multiple streams of data that must not interact with each other, we propose the use of the aforementioned virtual channel routing [3], shown in greater detail in Figure 2.

B. BCP Functional Units

1) Boolean Constraint Propagation (BCP): In software SAT solvers, Boolean Constraint Propagation (BCP) is a crucial step in determining whether or not a Product-of-Sums (POS) boolean expression is satisfiable (i.e., $\exists$ some assignment of values to variables in the expression which makes the expression evaluate to true). BCP focuses on evaluating the result of one sum (clause) in the product (expression), and the search is pruned/finished based on the following three conditions after assigning a selected variable a certain value:

1) Satsified: the assignment results in the clause evaluating to 1.
2) Conflict: the assignment results in a variable being in two states at once (i.e., the variable was already assigned a value in a previous iteration).
3) Unit Clause: the assignment still results in the clause evaluating to 0, but there remains only a single unassigned variable in the clause which can make it evaluate to 1 if assigned a certain value.

Then, after the clause is evaluated with the new assignment, the result must be propagated to all of the other clauses in the expression to update the search.

As previously mentioned, the functional units are mainly focused on parallelizing Boolean Constraint Propagation (BCP) and are based on the design implemented by Park et al. [1]. For the clause unit, We initially looked at the design proposed by Zhu et al. [4], but quickly determined based on area estimations that their design was not as scalable for our area constraint as we hoped. The HW-BCP clause units use a custom architecture which grants a very high degree of parallelism. The main feature which results in a very high degree of parallelism is their custom CAM-SRAM fusion which connects the CAM matchline to the SRAM wordline, where the CAM stores the variable ID, and the SRAM stores the value assigned to the variable. In doing so, this allows the variable lookup and update to happen simultaneously.

However, since we cannot expose the wordlines on the SRAM IP we are provided, we opted to use a D flip-flop oriented design for our clause units. We store the variable ID into a clause-length array of var_id-width registers if that variable appears in the clause. Then, we use another clause-length array of 2-bit registers to store the variable value (0, 1, or "x" for unassigned variables), and another clause-length array of FFs to store each variable's polarity (whether or not it appears negated in the expression, with a 1 denoting a non-negated variable).

Each BCP Function Unit is organized as a bank of clause units. Each clause unit is responsible for locally holding clause information, accepting new state, and emitting new state.

These clause units are then organized into banks to share hardware resources when interfacing with the NoC.

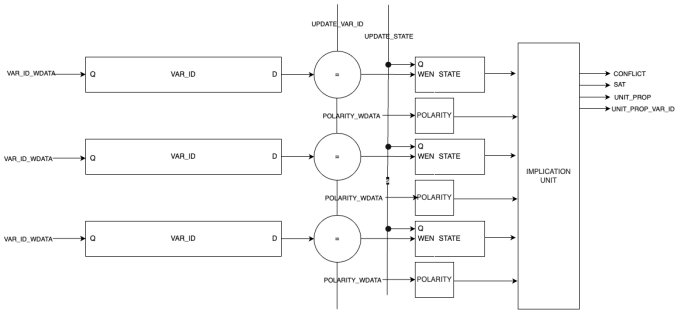

Fig. 3. Clause Unit

In the Clause Unit, a variable ID is given as input, as well as a desired value to assign to it. Then, the unit will evaluate the previously mentioned conditions as follows:

1) Satsified: the assignment is forwarded into the evaluation logic, and if the evaluation logic returns a 1 with this new assignment, the clause is satsified, and asserts the satisfied signal.
2) Conflict: using the inputted variable ID, the new assignment is checked against the previously assigned value by indexing into the variable value FFs; if it is found that

the assignment conflicts with the previous assignment, then the BCP unit asserts the conflict signal.

3) Unit Clause: within the BCP unit, two counters are used to track the number of variables present in the clause and the number of assigned variables in the clause. If the number of variables assigned + 2 (because we are forwarding the new assignment) is equal to the number of variables present in the clause and the clause is still not yet satisfied, then the BCP unit asserts the unit clause signal. A flag is also raised in case the NoC is busy, such that the clause may be propagated later.

Wesley has already written some RTL logic for the Clause Units and synthesized it using the FreePDK45 standard cell library, so we have some area estimates based on the number of variables the Clause unit supports:

1) 10-bit variable ID, 5-variable clauses: 641 μm^2
2) 10-bit variable ID, 500-variable clauses: 58272 μm^2

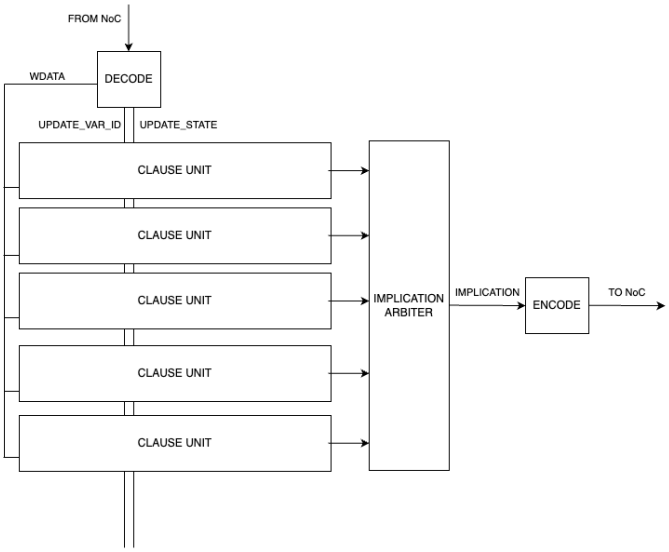

Fig. 4. Clause Bank

At the bank level, a set of Clause Units share the update lines, and a decoder and encoder. The decoder is responsible for taking commands of the NoC and translating them to actions within the Clause Units. All the implications generated by the Implication Unit are then arbitrated and encoded such that any Unit Clauses can propagate their implications through the encoder.

With this we estimate the area that a 512 variable problem with 512 clauses with 5 variables per clause could fit comfortably at around 0.328 mm^2.

If our banks wanted to support clause learning, another module would be included in the implication arbiter that tracks the implication level, a mechanism used to tag implications with the order in which they were generated. This tagging can then be used in the CPU to isolate the most important implications and write a new clause representing said implications.

C. CPU

To run the DPLL algorithm, we will need a CPU to generate the clauses and distribute them to the various BCP FUs. As the code is highly repeatable and does not require long wait times on other instructions, we plan to use a RISC-V pipelined core to handle the logic for the DPLL algorithm. This core takes up minimal area, thereby allowing us to have more opportunities to increase the number of BCP FUs to further increase the rate of acceleration.

Along with the CPU logic, we will be adding program memory using SRAMs. Since the DPLL algorithm is not too large, and we are offloading the BCP to hardware, our program will not need too much memory. As such, we decided to use SRAMs to store our program data so that it is easy for the CPU to access data quickly.

The basic software model for DPLL has been written, and the scaling laws for how much memory a certain problem requires have also been calculated.

We also leave ourselves open to adding certain optimizations that modern SAT solvers use, such as clause learning, clause deletion, and clause strengthening. Many of these additions are CPU memory-limited, while the hardware is quite simple (see the BCP Functional Units), but the software can grow.

IV. Timeline

A. Algorithm Analysis (Late May)

Identify key markers to accelerate and improve algorithm performance via software modeling.

B. Architectural Design (Early July)

Finalize architectural design, behavioral and functional specifications

C. RTL Design & Verification (July)

Finish first pass Behavioral RTL for individual components, NOC, Functional Units start verification for functional correctness and coverage.

D. RTL Finalization and Synthesis (Early August)

Addition of critical DTF components, area and timing analysis and correction.

E. Floorplanning and IP Analysis (August)

Determine geometric locations of SRAMs, CPU, and Functional Units.

F. Physical Layout (September)

Automating Physical design flows and setting up toolchains.

V. Pre-Silicon Verification

A. Toolchain

For our testbench, we will use the Universal Verification Methodology (UVM) 1.2 library, which enables easier stimulus randomization and constraint checking of DUT, as well as easier reuse of the testbench for different components in our architecture. UVM is available on the RHEL8 machines in UIUC.

B. Approach

Developing a verification testbench and software model will happen in tandem with RTL, with a different team member in charge of the two tasks to ensure the same "bug" is not implemented in both the RTL and checker. The strategy would be to first develop verification components (UVCs) for the leaf nodes in our architecture, i.e. the Clause Units, followed by the Clause Bank Interface (and Implication Arbiter), followed by the routing unit for our NOC. This is because the UVCs for the child node components would have to be fully functional before we can have a testbench to test the parent nodes.

C. Clause

The Clause design is relatively straightforward - a small number of variables, with input/output wires to receive and propagate implications, output signal to indicate it has become a "unit" Clause, and general load/store functionality. Hence, we should be able to achieve 100 percent functional coverage through a randomized testbench and software model checker, without needing many targeted tests.

D. Boolean-Constraint-Propagation Functional Unit

The BCP unit would require a driver simulating a switch to send and receive implications, to ensure it functions not just in isolation. Given some variables exist outside of a BCP, a software model would be required to track implication states external to the BCP. While it may be impossible to get a complete coverage crossing all features, we should be able to get full coverage individually on the state/FSM, the external interface to the switch, and the implication levels encountered.

E. System Architecture

For the router, we need to use UVM's virtual sequencer feature in order to coordinate activity at different switches, in order to exhaust important scenarios. Some scenarios that we would have to test in verification are

- simultaneous insertion of flits with similar destination addresses, to flood a virtual channel from a single source/stall some flits
- simultaneous insertion of flits with multiple addresses, to open as many virtual channels as possible from a single source
- forcing many virtual channels to send to the same destination, forcing the switch allocator to arbitrate
- injecting malformed packets to test error checking at Switch and BCP level

Besides basic field coverage on the interfaces, we would also want to monitor the usage of the mesh vs torus networks, as well as delay coverage on traffic through the switches to ensure congestion/starvation does not cause the design to fail.

Due to the complexity of the network design, we will require several "stimulus modes" in our randomized test bench in order to hit some edge cases in our coverage.

VI. Post-Silicon Validation

For Post-Silicon Validation, debug and tuning, we will be communicating with the chip via a JTAG interface. This interface will allow us to send various test messages to the system under test (SUT). Furthermore, this interface will allow us to read the different system registers that we have.

To build the JTAG interface, we will need to develop the main TAP controller that is responsible for receiving test data in (TDI) and sending test data out (TDO). The TAP controller will consist of the control logic of our custom JTAG FSM, and the SERDES required to process data coming in and data being sent out.

For DFT, we will implement the following methods to ensure the individual IP blocks are working correctly, and to ensure that the interactions between the IP blocks on the SUT is accurate:

1) Scan Chain: Allows for register values to be exposed and read correctly
2) NoC BIST: Enables us to detect faults in our routing networks

A. Scan Chain

A scan chain is used to efficiently transmit the values of system registers to an external debug tool. To enable the scan chain, we convert all flip flops and registers to scan FFs and scan registers. To do so, we need to add a 2:1 mux to control whether the input data is scan input or a data input. Furthermore, we will need to add a system wide scan enable signal that will be the select bit for the 2:1 mux. Additionally, we will need to switch the clock signal frequency so that no data is lost when transmitting through the TAP controller and PCB trace to the hardware debug tool. This is to take into account the signal propogation delay being longer on the PCB traces due to higher impedances

B. NoC BIST

The NoC is the most critical IP in our system as it is the main method of communication between the various BCP FUs and Control Unit. As we will have a number of routers on the network, implementing a BIST for all the routers will enable us to detect faults quicker on our chips and also give us a deeper insight on what directed tests we should run to further pinpoint any issues should they arise. At a high level, there are 2 kinds of faults we will be concerned with on the NoC.

1) Routing faults: Since most of the routing in our NoC is a broadcast signal, the biggest cause for concern here is that all inputs from any ports (NSEW) get broadcasted to all other ports correctly. To test this, we will develop a BIST with a pattern generator which will generate random data packets that will be sent as stimuli to the FIFO input queues. The test controller will be responsible for routing these stimuli to the different input ports. Lastly, a pattern analyser will gather the outputs of the output ports to ensure that all unique test packets have been received at all output ports

2) Network Interface faults: NI faults occur when data from the BCP FUs (resources) are not packetized correctly for transport on the NoC mesh. In our design, there are a number of data fields that need to be sent on the network such a the var_id, var_status, implication, conflict etc. We need to ensure that the correct data is being sent and received on the network as incorrect packetization will lead to a failure of the algorithm. To achieve this, a pattern generator + analyser will be tagged to either side of the resource port. This allows us to create a stimulus packet on the input side and ensure that it is correctly packetized at the output of the input queue. Additionally, we will create a stimulus network packet on the output side of the resource port. This packet will then be decoded on the output of the output queue and ensure it is correctly depacketized.

The 2 DFT mechanisms will enable us to run deeper tests by running the pattern generation over multiple routers and sending them around for a pre-determined number of cycles depending on the longest path latency. Using the scanchain, we will be able to read the final states of the router switches allowing us to run system level tests on the NoC

VII. Pin-Out

Power

- 2x VDD
- 2x VSS

Regular I/O

- 1x Is_SAT
- 2x var_status
- 10x var_id[9:0]

Debug I/O

- JTAG interface[1]
  - 1x TCK
  - 1x TMS
  - 1x TDI
  - 1x TDO
- 24x Reserved

VIII. Team Qualifications

1) Hrishi - First-Year MS Student
   - Relevant Coursework: ECE 411, ECE 425, ECE 483, ECE 342, ECE 408
   - Doing machine learning systems research advised by Professor Nam Sung Kim
   - Industry: Interning at Astera Labs in Design Verification, writing UVM testing for fabric switches and CXL memory controllers.
   - Designed HW-SW in-network compression protocol for LLM training, wrote RTL for vector database accelerator, and developed peer-to-peer SNIC to accelerator data transfer scheme for research
   - Role: Algorithm, Architecture, RTL, PD
2) Wesley - Second-Year MS Student
   - Relevant Coursework: ECE 511, CS 533, ECE 411, ECE 425, ECE 498 SJP, ECE 462
   - Doing networking systems research advised by Professor Nam Sung Kim
   - Industry: Embedded SWE Intern @ Motorola Solutions, SoC DV Intern @ Qualcomm, Post-Si Validation Intern @ Arm, System IP Engineer Intern @ Arm
   - Wrote and verified RTL for a FU inside a behavioral HDL model of the FHE Accelerator as part of the semester-long course project for ECE 498 SJP
   - Role: RTL, Verification, PD
3) Parithimaal - Senior in Computer Engineering
   - Relevant Coursework: ECE411, ECE498NSU, ECE342, CS426 (concurrent), ECE425 (audit)
   - GPU DV Intern @ Apple, writing UVM testbenches and software models in systemverilog for graphics caches
   - Have experience writing RTL design and UVM testbenches with both Cadence and Synopsys tools
   - ECE385 and ECE391 Course Assistant
   - Verification, RTL
4) Aaditya - Senior in Computer Engineering
   - Relevant Coursework: ECE 482, ECE 411, ECE464, ECE342, CS426 (concurrent)
   - SoC RTL Design Intern @ Rivos; Power Management Architecture Validation Intern @ AMD working on power management architecture for Zen
   - Developed JTAG scheme for power management controllers, found solution to silicon design bug, and developed ways to reduce sleep state latency
   - PCB design and interconnect debug experience through eco illini supermileage
   - Arch, RTL, PD, Bring-Up
5) Cher Rui - Senior in Computer Engineering
   - Relevant Coursework: ECE 411, ECE 425, ECE 391
   - Experience: ECE 411 and ECE 391 Course Assistant
   - Role: Architecture, RTL, PD
6) Kai - Junior in Computer Engineering
   - Relevant Coursework: ECE 411, ECE 425
   - Doing research on AI in nutrition, advised by Volodymyr Kindratenko

[1]The TDI and TDO widths may increase depending on the number of reserved pins not used for other debug

- Designed a 3D rendering accelerator for ECE 385 final project
- Role: Algorithm, PD

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